

# HUL7281

## Hologram Unit

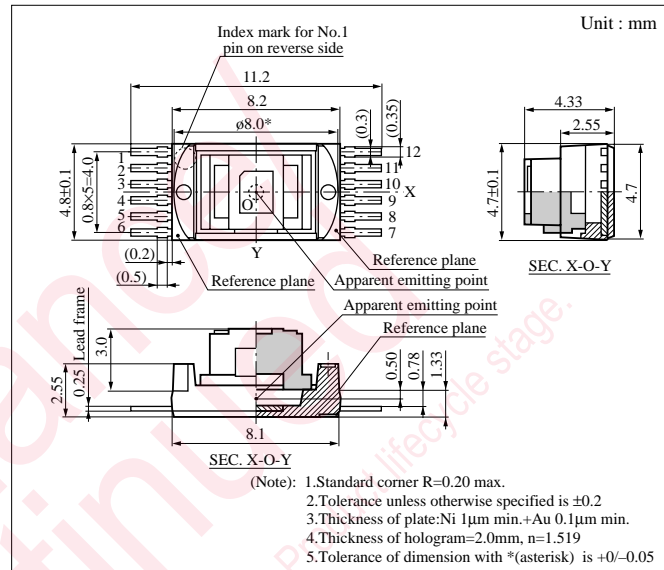
For optical information processing

### ■ Features

- Smaller package size achieved through micro-mirror integration  
(4.8 × 8.2 × 4.3 mm)
- Fast response ( $f_C = 24$  MHz)
- Focus error signal detection : SSD method
- Tracking error signal detection : 3 beam method
- Low-power semiconductor laser included

### ■ Application

- CD-ROM drives  
(supports 8- to 16-time speed CD-ROM drives)



### ■ Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

Parameter	Symbol	Ratings	Unit
Laser beam output* <sup>1</sup>	$P_O$	0.3	mW
Reverse voltage	Laser	$V_{R(LD)}$	2 V
	Monitor	$V_{R(mon)}$	6 V
Supply voltage	$V_R$	6	V
Operating ambient temperature	$T_{opr}$	-10 to +60	$^\circ\text{C}$
Storage temperature	$T_{stg}$	-40 to +85	$^\circ\text{C}$

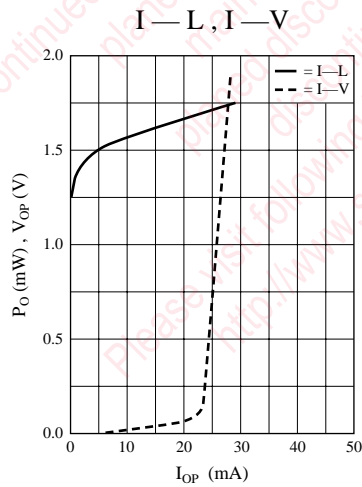
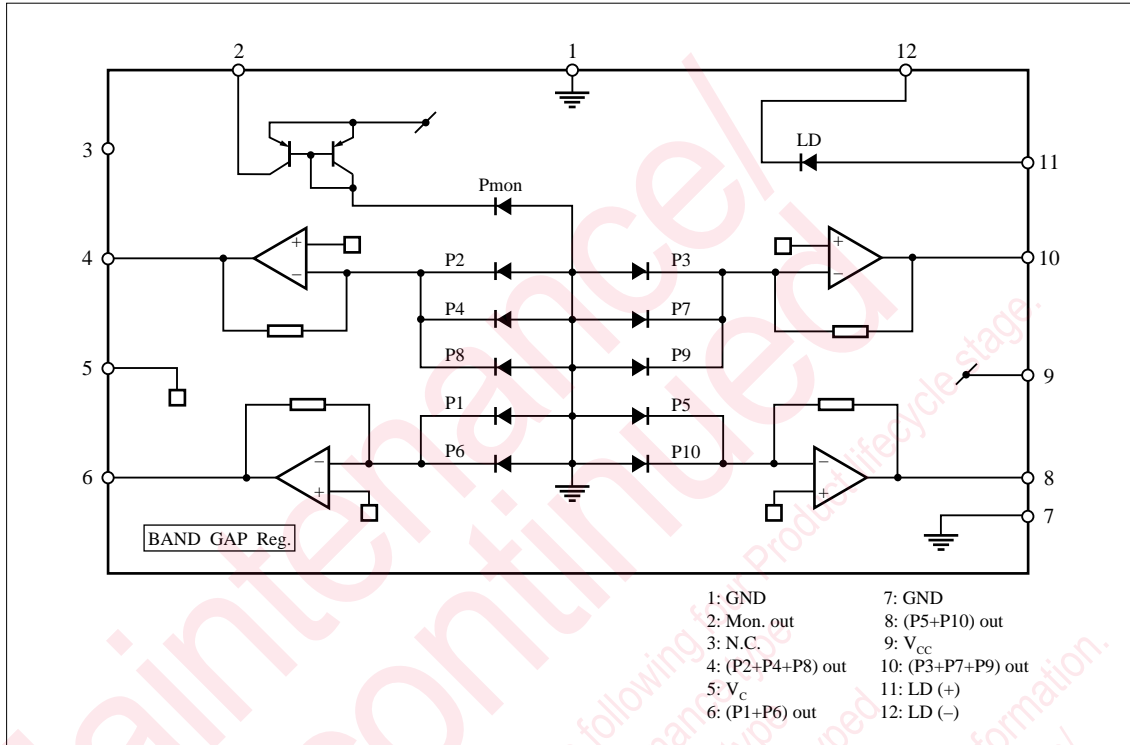
\*<sup>1</sup> Light emitting output through objective lens

### ■ Electro-Optical Characteristics ( $T_a = 25^\circ\text{C}$ )

Parameter	Symbol	Conditions	min	typ	max	Unit
Laser beam output* <sup>1</sup>	$P_O$	CW		0.18	0.25	mW
Operating current	$I_{OP}$	CW $V_{RF} = 420\text{mV}$ , $V_{CC} = 5\text{V}$	25	35	45	mA
Operating voltage	$V_{OP}$	CW $V_{RF} = 420\text{mV}$ , $V_{CC} = 5\text{V}$		1.9	2.4	V
Oscillating wavelength	$\lambda_L$	CW $V_{RF} = 420\text{mV}$ , $V_{CC} = 5\text{V}$	775	795	815	nm
Focus error signal amplitude	$V_{FE}$	CW $V_{RF} = 420\text{mV}$ , $V_{CC} = 5\text{V}$	180	300	420	mV
Tracking error signal amplitude	$V_{TE}$	CW $V_{RF} = 420\text{mV}$ , $V_{CC} = 5\text{V}$	170	280	400	mV
Focus error signal pull-in range	$D_{FE}$	CW $V_{RF} = 420\text{mV}$ , $V_{CC} = 5\text{V}$	9	12	16	$\mu\text{m}$
Frequency characteristics (-3 dB)	$f_C$		16	24		MHz

\*<sup>1</sup> Light emitting output through objective lens

■ Block Diagram of Circuit Functions



# Caution for Safety

 **DANGER**

## ■ This product contains Gallium Arsenide (GaAs).

GaAs powder and vapor are hazardous to human health if inhaled or ingested. Do not burn, destroy, cut, cleave off, or chemically dissolve the product. Follow related laws and ordinances for disposal. The product should be excluded from general industrial waste or household garbage.

## ■ Do not touch or look into the laser beam directly.

The laser beam may cause injury to the eye or skin, or loss of eyesight.

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